

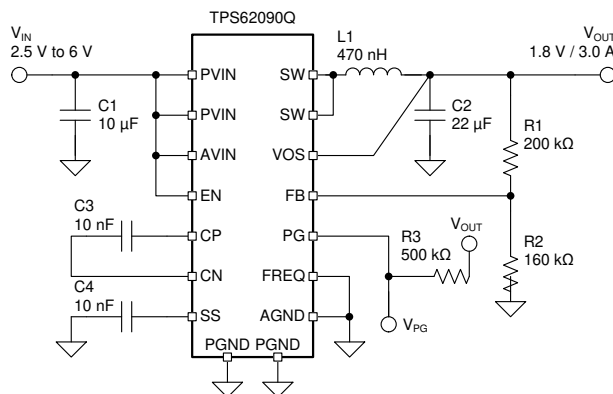
TPS62090-Q1 3A 高効率同期整流降圧コンバータ、 DCS-Control™ 付き

1 特長

- 車載アプリケーション認定済み
- 下記内容で AEC-Q100 認定済み:
 - デバイス温度グレード 1: -40°C ~ 125°C の接合部動作時温度範囲
 - デバイス HBM ESD 分類レベル H2
 - デバイス CDM ESD 分類レベル C6
- 入力電圧範囲: 2.5V ~ 6V
- DCS-Control™
- 95% のコンバータ効率
- パワーセーブ・モード
- 動作時の静止電流: 20µA
- 100% デューティ・サイクル動作による最小のドロップアウト電圧
- 標準スイッチング周波数 2.8MHz および 1.4MHz
- 出力電圧 0.8V ~ V_{IN} まで可変
- 出力放電機能
- 調整可能なソフト・スタート
- ヒックアップ短絡保護機能
- 出力電圧トラッキング
- 選択の幅が広い出力コンデンサ
- 3mm × 3mm 16 ピン QFN パッケージで供給
- 新製品を利用可能: TPS62813-Q1、6V 降圧コンバータ、2mm × 3mm ウェットابل・フランク付き QFN パッケージ

2 アプリケーション

- 車載用アプリケーション
- 分散型電源
- プロセッサ電源
- バッテリー駆動アプリケーション



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代表的なアプリケーション

3 概要

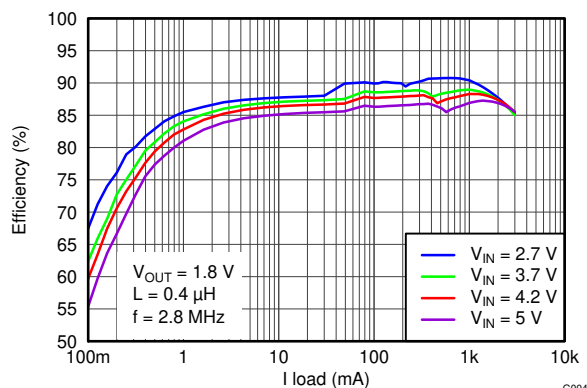
TPS62090Q デバイスは、高周波数の同期整流降圧コンバータで、小型で高効率のソリューションに最適化されており、バッテリー駆動のアプリケーションに適しています。最大の効率を実現するため、このコンバータは、パルス幅変調 (PWM) モードで動作します。公称スイッチング周波数は、2.8MHz/1.4MHz で、負荷電流が小さいときには自動的にパワーセーブ・モードの動作に移行します。分散型電源およびポイント・オブ・ロード・レギュレーションで使用するとき、他の電圧レールへの電圧トラッキングが可能で、10µF から 150µF まで、さらにそれ以上の出力容量を許容できます。このデバイスは DCS-Control™ トポロジを使用して、非常に優れた負荷過渡性能と、出力電圧の正確なレギュレーションを実現しています。

SS (ソフトスタート) ピンを使って出力電圧のスタートアップ・ランプを制御できるため、スタンドアロン電源としても、またトラッキング構成でも動作できます。イネーブル・ピンおよびパワー・グッド・ピンの構成により、電源シーケンスも可能です。パワー・セーブ・モードでは、標準 20µA の静止電流で動作します。パワー・セーブ・モードへの遷移は自動的にかつシームレスに行われるため、負荷電流範囲の全体にわたって高い効率が維持されます。

製品情報

部品番号	パッケージ ⁽¹⁾	本体サイズ (公称)
TPS62090Q	QFN (16)	3.00mm × 3.00mm

- (1) 利用可能なすべてのパッケージについては、このデータシートの末尾にある注文情報を参照してください。



効率

G004



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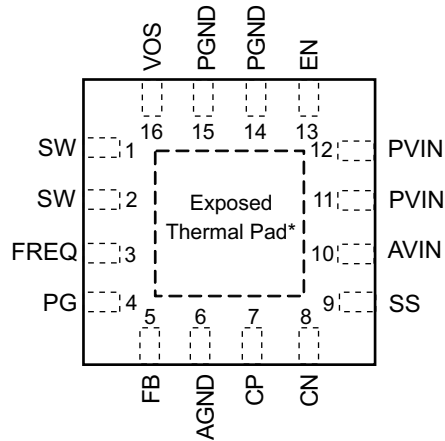
4 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Changes from Revision B (December 2016) to Revision C (November 2021)	Page
• 文書全体にわたって表、図、相互参照の採番方法を更新.....	1
• TPS62813-Q1 へのリンクを追加.....	1

Changes from Revision A (August 2013) to Revision B (December 2016)	Page
• 「ピン構成および機能」セクション、「ESD 定格」表、「機能説明」セクション、「デバイスの機能モード」セクション、「アプリケーションと実装」セクション、「電源に関する推奨事項」セクション、「レイアウト」セクション、「デバイスおよびドキュメントのサポート」セクション、「メカニカル、パッケージ、および注文情報」セクションを追加.....	1
• Added CN and CP pin voltage.....	4
• Added typical value of V_H and V_L	5
• Added new graphs to the <i>Typical Characteristics</i> section	6
• Added Switching frequency curves for $V_{OUT} = 1\text{ V}$ and $V_{OUT} = 3.3\text{ V}$	6
• Added <i>Enable and Disable (EN)</i> section.....	9
• Added Hiccup current limit during startup	9
• Added <i>Charge Pump (CP, CN)</i> section.....	11
• Updated <i>Input and Output Capacitor Selection</i> section.....	16
• Moved graphs from <i>Typical Characteristics</i> to <i>Application Curves</i> section	17
• Updated TPS62090Q Layout.....	22

5 Pin Configuration and Functions



The exposed thermal pad is connected to AGND.

5-1. RGT Package 16-Pin QFN With Exposed Thermal Pad Top View

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Voltage ⁽²⁾	PVIN, AVIN, FB, SS, EN, FREQ, VOS	-0.3	7	V
	SW, PG	-0.3	$V_{IN} + 0.3$	
	CN, CP	-0.3	$V_{IN} + 7$	
Power Good sink current, PG			1	mA
Operating junction temperature, T_J		-40	150	°C
Storage temperature, T_{stg}		-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to network ground terminal.

6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 ⁽¹⁾	±2500
		Charged-device model (CDM), per AEC Q100-011	±1500

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

For additional information, see [セクション 8.1](#).

		MIN	MAX	UNIT
V_{IN}	Input voltage	2.5	6	V
T_J	Operating junction temperature	-40	125	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TPS62090-Q1	UNIT
		RGT (QFN)	
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	45.6	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	58.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	19	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	1.1	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	19	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	4	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics

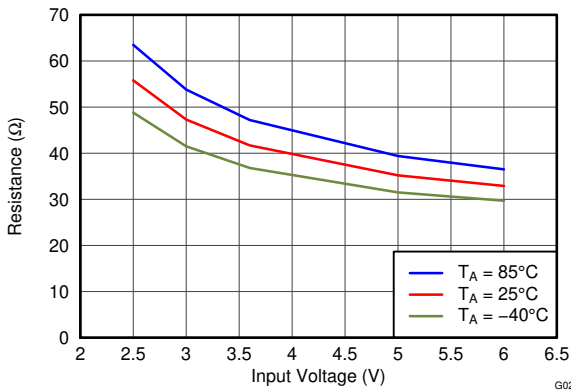
$V_{IN} = 3.6\text{ V}$, $T_J = -40^\circ\text{C}$ to 125°C , typical values are at $T_J = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY						
V_{IN}	Input voltage range		2.5		6	V
I_{QIN}	Quiescent current	Not switching, FB = FB +5 %, Into PVIN and AVIN		20		μA
I_{sd}	Shutdown current	Into PVIN and AVIN		0.6	5	μA
UVLO	Undervoltage lockout threshold	V_{IN} falling	2.1	2.2	2.3	V
	Undervoltage lockout hysteresis			200		mV
	Thermal shutdown	Temperature rising		150		$^\circ\text{C}$
	Thermal shutdown hysteresis			20		$^\circ\text{C}$
CONTROL SIGNALS EN, FREQ						
V_H	High level input voltage	$V_{IN} = 2.5$ to 6 V	1	0.65		V
V_L	Low level input voltage	$V_{IN} = 2.5$ to 6 V		0.6	0.4	V
I_{lkg}	Input leakage current	EN, FREQ = GND or V_{IN}		10	100	nA
R_{PD}	Pulldown resistance			400		k Ω
SOFT START						
I_{SS}	Soft-start current		6.3	7.5	8.7	μA
POWER GOOD						
V_{th}	Power good threshold	Output voltage rising		95%		
		Output voltage falling		90%		
V_L	Low level voltage	$I_{(sink)} = 1\text{ mA}$			0.4	V
I_{PG}	PG sinking current				1	mA
I_{lkg}	Leakage current	$V_{PG} = 3.6\text{ V}$		10	200	nA
POWER SWITCH						
$R_{DS(on)}$	High-side FET on-resistance	$I_{SW} = 500\text{ mA}$		50		m Ω
	Low-side FET on-resistance	$I_{SW} = 500\text{ mA}$		40		m Ω
I_{LIM}	High-side FET switch current limit		3.7	4.6	5.5	A
f_s	Switching frequency	FREQ = GND, $I_{OUT} = 3\text{ A}$		2.8		MHz
		FREQ = V_{IN} , $I_{OUT} = 3\text{ A}$		1.4		MHz
OUTPUT						
V_s	Output voltage		0.8		V_{IN}	V
R_{od}	Output discharge resistor	EN = GND, $V_{OUT} = 1.8\text{ V}$		200		Ω
V_{FB}	Feedback regulation voltage			0.8		V
V_{FB}	Feedback voltage accuracy ^{(1) (2)}	$V_{IN} \geq V_{OUT} + 1\text{ V}$	$I_{OUT} = 1\text{ A}$, PWM mode	-1.4%	1.4%	
			$I_{OUT} = 0\text{ mA}$, FREQ = 2.8 MHz, $V_{OUT} \geq 0.8\text{ V}$, PFM mode	-1.4%	3%	
			$I_{OUT} = 0\text{ mA}$, FREQ = 1.4 MHz, $V_{OUT} \geq 1.2\text{ V}$, PFM mode	-1.4%	3%	
			$I_{OUT} = 0\text{ mA}$, FREQ = 1.4 MHz, $V_{OUT} < 1.2\text{ V}$, PFM mode	-1.4%	3.7%	
I_{FB}	Feedback input bias current	$V_{FB} = 0.8\text{ V}$		10	100	nA
V_{OUT}	Output voltage accuracy ⁽²⁾	$V_{IN} \geq V_{OUT} + 1\text{ V}$, fixed output voltage, $f = 2.8\text{ MHz}$, $L = 0.47\text{ }\mu\text{H}$, $C_{OUT} = 22\text{ }\mu\text{F}$ or $f = 1.4\text{ MHz}$, $L = 1\text{ }\mu\text{H}$, $C_{OUT} = 22\text{ }\mu\text{F}$	$I_{OUT} = 1\text{ A}$, PWM mode	-1.4%	1.4%	
			$I_{OUT} = 0\text{ mA}$, FREQ = high and low, PFM mode	-1.4%	2.5%	
	Line regulation	$V_{OUT} = 1.8\text{ V}$, PWM operation		0.016%		V
	Load regulation	$V_{OUT} = 1.8\text{ V}$, PWM operation		0.04%		A

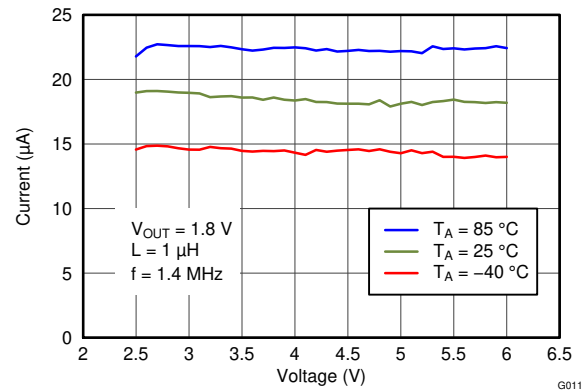
(1) For output voltages < 1.2 V, use a $2 \times 22\text{ }\mu\text{F}$ output capacitance to achieve 3% output voltage accuracy.

(2) For more information, see [セクション 7.4.2](#).

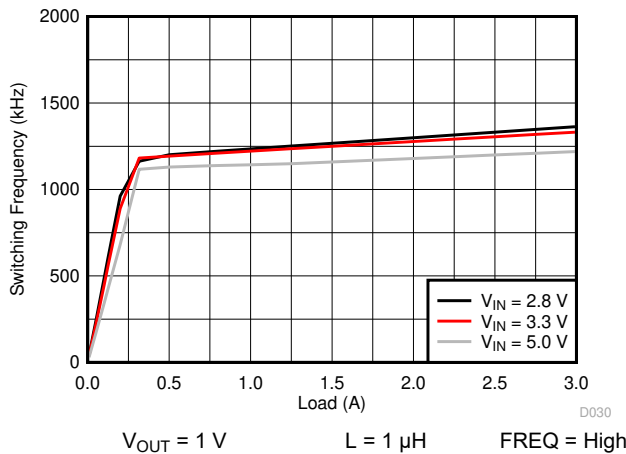
6.6 Typical Characteristics



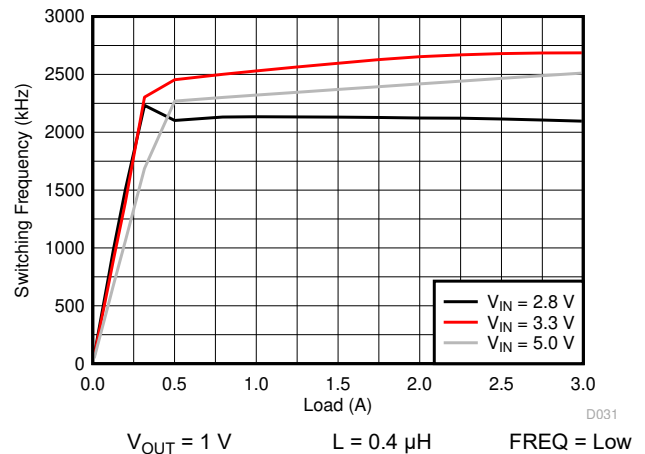
6-1. High-Side FET ON-Resistance vs Input Voltage



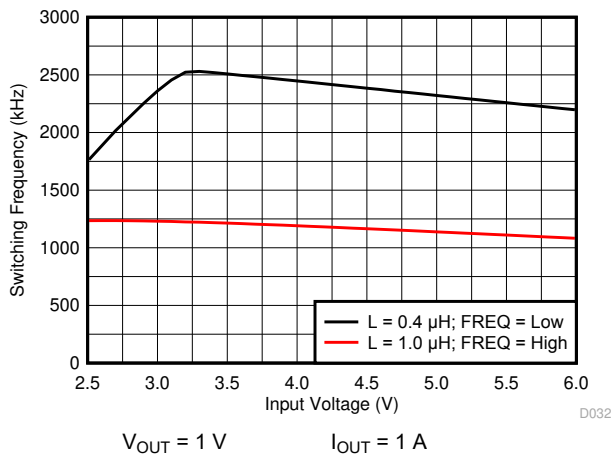
6-2. Quiescent Current vs Input Voltage



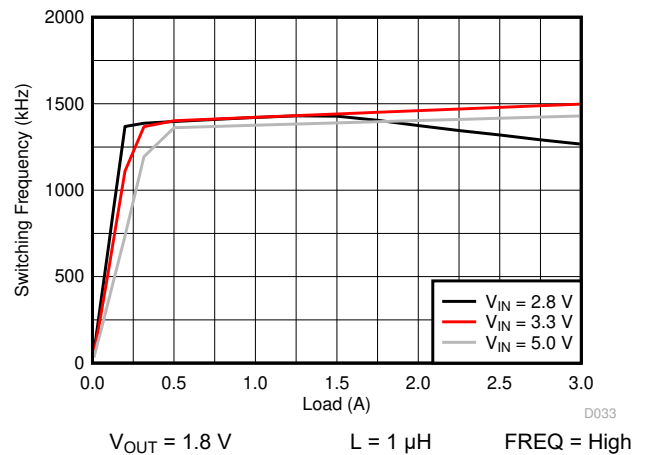
6-3. Switching Frequency vs Load Current



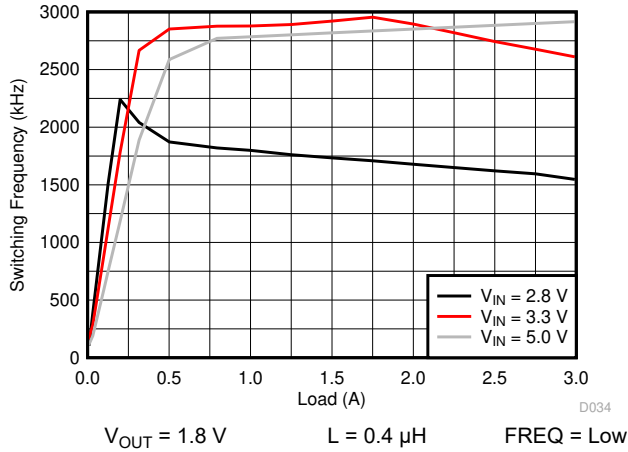
6-4. Switching Frequency vs Load Current



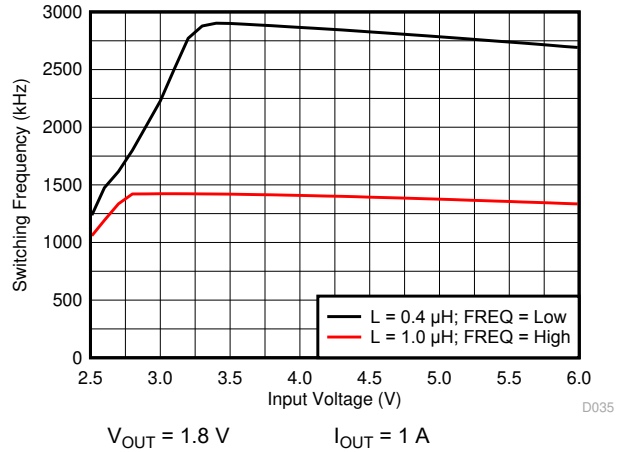
6-5. Frequency vs Input Voltage



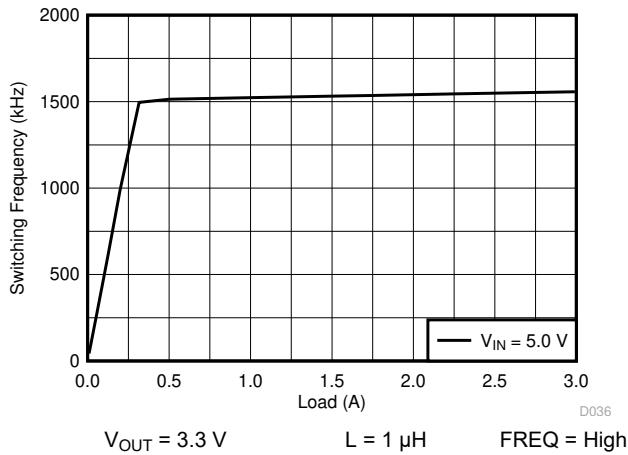
6-6. Frequency vs Load Current



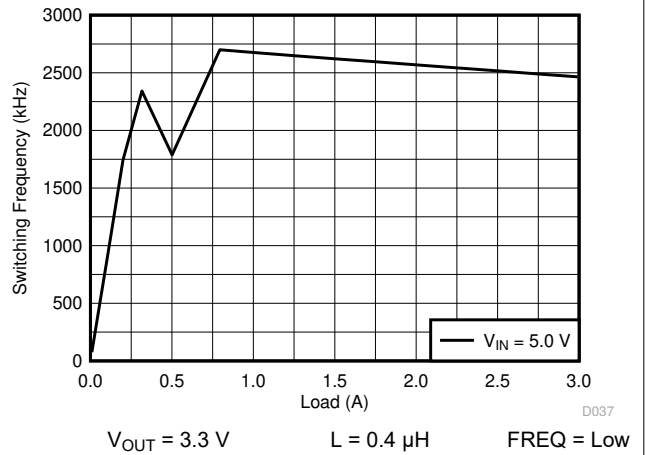
6-7. Frequency vs Load Current



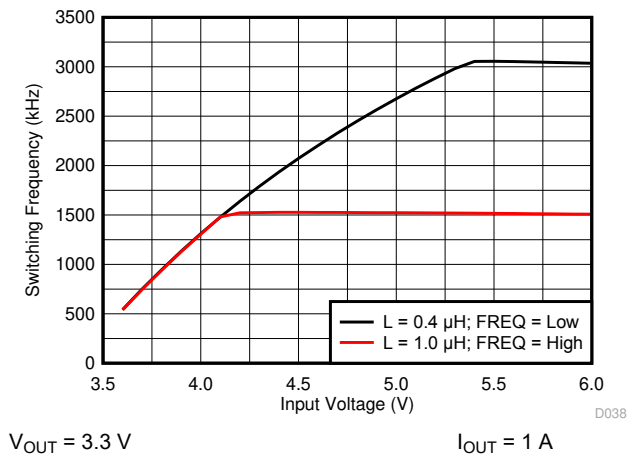
6-8. Frequency vs Input Voltage



6-9. Frequency vs Load Current



6-10. Frequency vs Load Current



6-11. Frequency vs Input Voltage

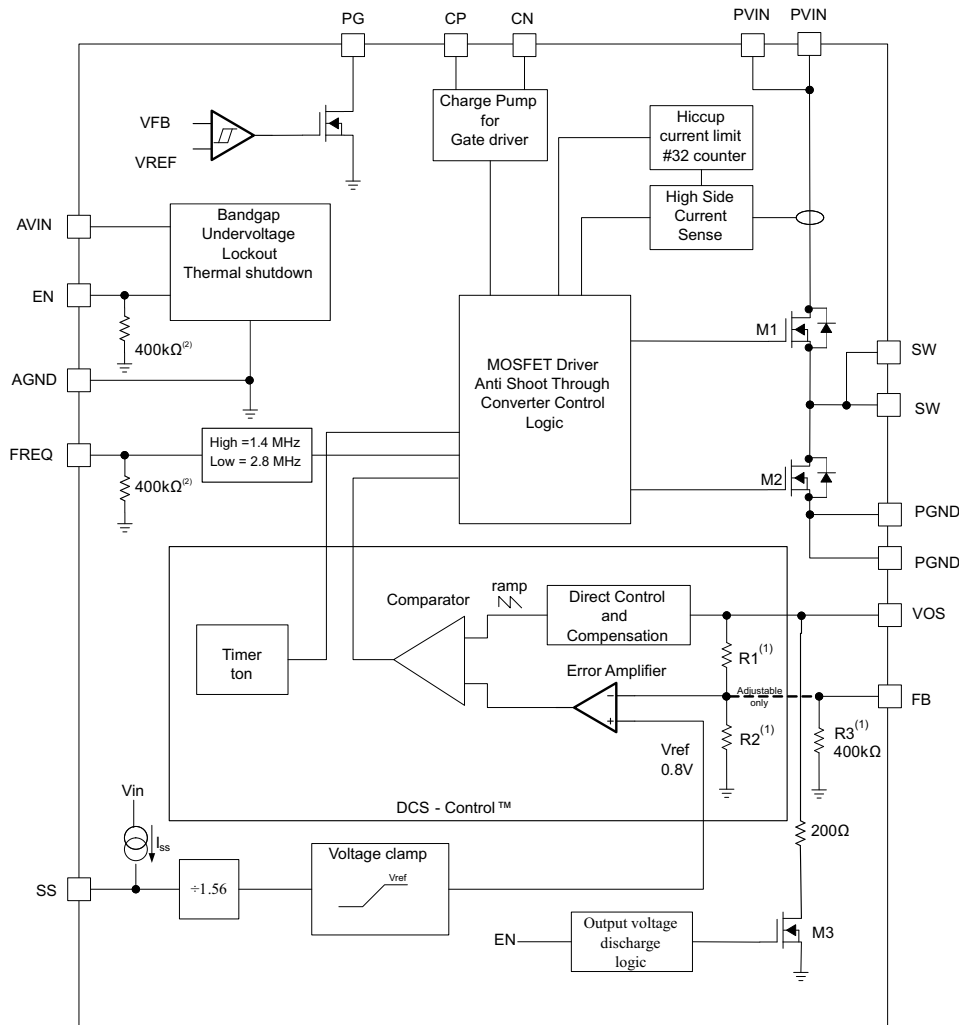
7 Detailed Description

7.1 Overview

The TPS62090Q synchronous switched mode converter is based on DCS-Control (Direct Control with Seamless transition into power save mode). DCS-Control is an advanced regulation topology that combines the advantages of hysteretic and voltage mode control.

The DCS-Control topology operates in Pulse Width Modulation (PWM) mode for medium to heavy load conditions and in power save mode at light load currents. In PWM, the converter operates with nominal switching frequency of 2.8 MHz or 1.4 MHz, having a controlled frequency variation over the input voltage range. As the load current decreases, the converter enters power save mode, reducing the switching frequency and minimizing the IC quiescent current to achieve high efficiency over the entire load current range. DCS-Control supports both operation modes (PWM and PFM) using a single building block with a seamless transition from PWM to power save mode without effecting the output voltage. The TPS62090Q device offers excellent DC-voltage regulation and load transient regulation, combined with low output voltage ripple, to minimize interference with RF circuits.

7.2 Functional Block Diagram



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(2) The resistors are disconnected when the pins are high.

7.3 Feature Description

7.3.1 Enable and Disable (EN)

The device is enabled by setting the EN pin to a logic high. Accordingly, shutdown mode is forced if the EN pin is pulled low with a shutdown current of typically 0.6 μA . In shutdown mode, the internal power switches as well as the entire control circuitry are turned off. An internal resistor of 200 Ω discharges the output through the VOS pin smoothly. An internal pulldown resistor of 400 k Ω is connected to the EN pin when the EN pin is low. The pulldown resistor is disconnected when the EN pin is high.

7.3.2 Soft Start (SS) and Hiccup Current Limit During Start-Up

To minimize inrush current during start-up, the device has an adjustable soft start depending on the capacitor value connected to the SS pin. The device charges the soft-start capacitor with a constant current of typically 7.5 μA . The feedback voltage follows this voltage with a fraction of 1.56 until the internal reference voltage of 0.8 V is reached. The soft-start operation is complete when the voltage at the soft-start capacitor has reached typically 1.25 V. The soft-start time is calculated using 式 1. The larger the soft-start capacitor, the longer the soft-start time. The relation between soft-start voltage and feedback voltage is estimated using 式 2.

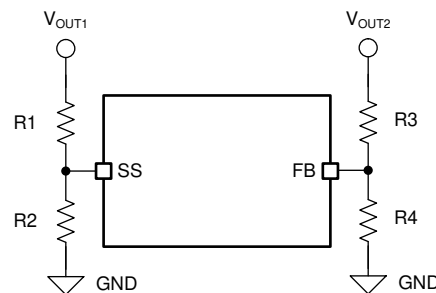
$$t_{\text{SS}} = C_{\text{SS}} \times \frac{1.25\text{V}}{7.5\mu\text{A}} \quad (1)$$

$$V_{\text{FB}} = \frac{V_{\text{SS}}}{1.56} \quad (2)$$

During start-up, the switch current limit is reduced to 1/3 (approximately 1.5 A) of its typical current limit of 4.6 A. Once the output voltage exceeds typically 0.6 V, the current limit is released to its nominal value. The device provides a reduced load current of approximately 1.5 A when the output voltage is below typically 0.6 V. Due to this, a small or no soft-start time may trigger the short-circuit protection during start-up especially for larger output capacitors. This is avoided by using a larger soft-start capacitance to extend the soft-start time. See セクション 7.3.4 for details of the reduced current limit during start-up. Leaving the soft-start pin floating sets the minimum start-up time (around 50 μs).

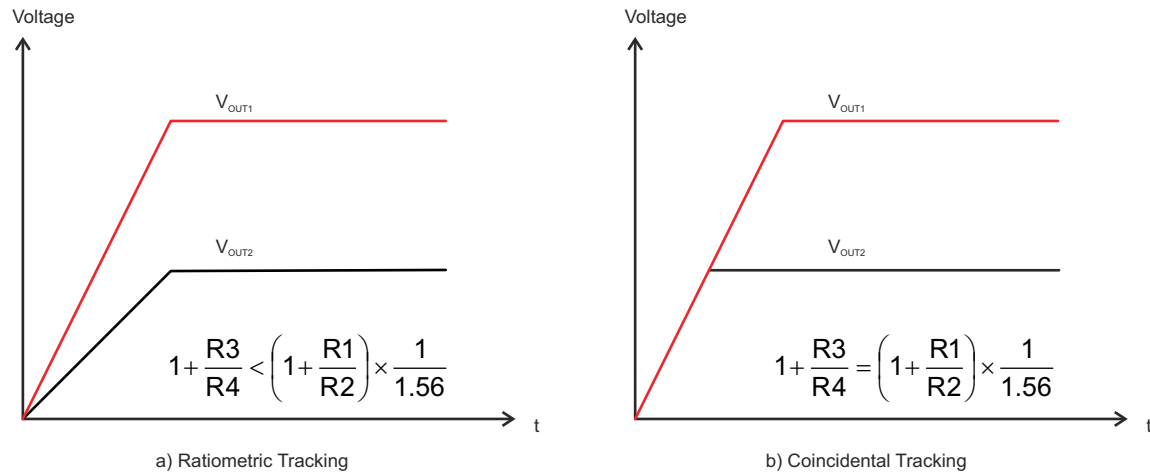
7.3.3 Voltage Tracking (SS)

The SS pin is externally driven by another voltage source to achieve output voltage tracking. The application circuit is shown in 図 7-1. The internal reference voltage follows the voltage at the SS pin with a fraction of 1.56 until the internal reference voltage of 0.8 V is reached. The device achieves ratiometric or coincidental (simultaneous) output tracking, as shown in 図 7-2.



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図 7-1. Output Voltage Tracking



7-2. Voltage Tracking Options

The R2 value should be set properly to achieve accurate voltage tracking by taking 7.5- μ A soft start-up current into account. 1 k Ω or smaller is a sufficient value for R2.

For decreasing the SS pin voltage, the device does not sink current from the output when the device is in power save mode. So the resulting decreases of the output voltage may be slower than the SS pin voltage if the load is light. When driving the SS pin with an external voltage, do not exceed the voltage rating of the SS pin which is 7 V.

7.3.4 Short-Circuit Protection (Hiccup Mode)

The device is protected against hard short circuits to GND and overcurrent events. This protection is implemented by a two-level short-circuit protection. During start-up and when the output is shorted to GND, the switch current limit is reduced to 1/3 of the typical current limit of 4.6 A. When the output voltage exceeds typically 0.6 V, the current limit is released to the nominal value. The full current limit is implemented as a hiccup current limit. Once the internal current limits are triggered 32 times, the device stops switching and starts a new start-up sequence after a typical delay time of 66 μ S passed by. The device continues in this cycle until the high current condition is released.

7.3.5 Output Discharge Function

To ensure the device starts up under the defined conditions, the output discharges through the VOS pin with a typical discharge resistor of 200 Ω whenever the device shuts down. This discharge happens when the device is disabled or if thermal shutdown, undervoltage lockout or short-circuit hiccup mode is triggered.

7.3.6 Power Good Output (PG)

The power good output is low when the output voltage is below the nominal value. The power good becomes high impedance once the output is within 5% of regulation. The PG pin is an open-drain output and is specified to typically sink up to 1 mA. This output requires a pullup resistor to be monitored properly. The pullup resistor cannot be connected to any voltage higher than the input voltage of the device. The PG output is low when the device is disabled, in thermal shutdown, or in UVLO. The PG output can be left floating if unused.

7.3.7 Frequency Set Pin (FREQ)

The FREQ pin is a digital logic input which sets the nominal switching frequency. Pulling this pin to GND sets the nominal switching frequency to 2.8 MHz and pulling this pin high sets the nominal switching frequency to 1.4 MHz. Because this pin changes the switching frequency, it also changes the on-time during PFM mode. At 1.4 MHz the on-time is twice the on-time as operating at 2.8 MHz. This pin has an active pulldown resistor of typically 400 k Ω . For applications where efficiency is of highest importance, a lower switching frequency should be selected. A higher switching frequency allows the use of smaller external components, faster load transient response, and lower output voltage ripple when using same L-C values.

7.3.8 Undervoltage Lockout (UVLO)

To avoid mis-operation of the device at low input voltages, an undervoltage lockout is included. UVLO shuts down the device at input voltages lower than typically 2.2 V with a 200-mV hysteresis.

7.3.9 Thermal Shutdown

The device enters thermal shutdown once the junction temperature exceeds typically 150°C with a 20°C hysteresis.

7.3.10 Charge Pump (CP, CN)

The CP and CN pins must attach to an external 10-nF capacitor to complete a charge pump for the gate driver. This capacitor must be rated for the input voltage. TI does not recommend connecting any other circuits to the CP or CN pins.

7.4 Device Functional Modes

7.4.1 Pulse Width Modulation Operation

At medium to heavy load currents, the device operates with PWM at a nominal switching frequency of 2.8 MHz or 1.4 MHz depending on the setting of the FREQ pin. As the load current decreases, the converter enters the power save mode operation reducing the switching frequency. The device enters power save mode at the boundary to discontinuous conduction mode (DCM).

7.4.2 Power Save Mode Operation

As the load current decreases, the converter enters power save mode operation. During power save mode, the converter operates with reduced switching frequency in PFM mode and with a minimum quiescent current while maintaining high efficiency. The power save mode is based on a fixed on-time architecture following 式 3. When operating at 1.4 MHz, the on-time is twice as long as the on-time for 2.8-MHz operation, resulting in larger output voltage ripple, as shown in 図 8-11 and 図 8-12, and slightly higher output voltage at no load, as shown in 図 8-8 and 図 8-9. To have the same output voltage ripple at 1.4 MHz during PFM mode, either the output capacitor or the inductor value must be increased. As an example, operating at 2.8 MHz using 0.47-μH inductor gives the same output voltage ripple as operating with 1.4 MHz using 1-μH inductor.

$$\begin{aligned}
 \text{ton}_{2.8\text{MHz}} &= \frac{V_{\text{OUT}}}{V_{\text{IN}}} \times 360\text{ns} \\
 \text{ton}_{1.4\text{MHz}} &= \frac{V_{\text{OUT}}}{V_{\text{IN}}} \times 360\text{ns} \times 2 \\
 f &= \frac{2 \times I_{\text{OUT}}}{\text{ton}^2 \left(1 + \frac{V_{\text{IN}} - V_{\text{OUT}}}{V_{\text{OUT}}} \right) \times \frac{V_{\text{IN}} - V_{\text{OUT}}}{L}}
 \end{aligned} \tag{3}$$

In power save mode the output voltage rises slightly above the nominal output voltage in PWM mode, as shown in 図 8-8 and 図 8-9. This effect is reduced by increasing the output capacitance or the inductor value. This effect is also reduced by programming the output voltage of the TPS62090Q lower than the target value. As an example, if the target output voltage is 3.3 V, then the TPS62090Q is programmed to 3.3 V – 0.8%. As a result the output voltage accuracy is now –2.2% to +2.2% instead of –1.4% to 3%. The output voltage accuracy in PFM operation is reflected in the セクション 6.5 table and given for a 22-μF output capacitance.

7.4.3 Low-Dropout Operation (100% Duty Cycle)

The device offers low input to output voltage difference by entering 100% duty cycle mode. In this mode the high-side MOSFET switch is constantly turned on which is particularly useful in battery-powered applications to achieve longest operation time by taking full advantage of the whole battery voltage range. The minimum input voltage where the output voltage falls below the nominal regulation value is given by 式 4.

$$V_{\text{IN (min)}} = V_{\text{OUT}} + I_{\text{OUT}} \times (R_{\text{DS(on)}} + R_{\text{L}}) \tag{4}$$

Where

- $R_{DS(on)}$ = High side FET on-resistance
- R_L = DC resistance of the inductor

8 Application and Implementation

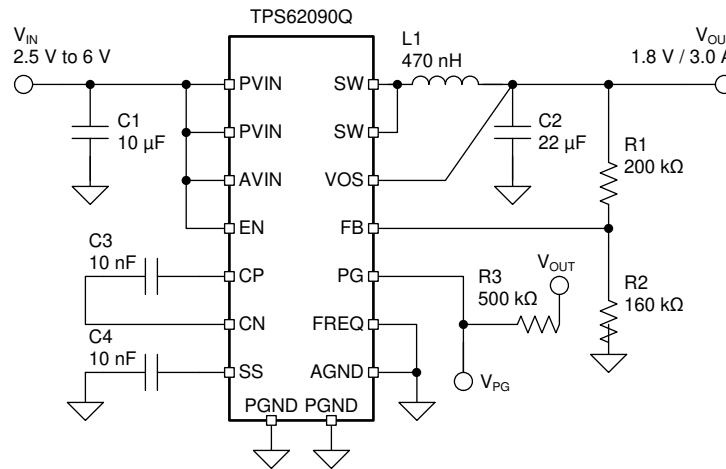
Note

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8.1 Application Information

The TPS62090-Q1 device is a high-frequency, synchronous, step-down converter optimized for small solution size, high efficiency, and is suitable for battery-powered applications.

8.2 Typical Application



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図 8-1. Test Circuit

8.2.1 Design Requirements

表 8-1 is a recommended list of components for the test circuit in 図 8-1.

表 8-1. List of Components

REFERENCE	DESCRIPTION	MANUFACTURER
TPS62090Q	High efficiency step-down converter	Texas Instruments
L1	Inductor: 1 μH, 0.47 μH, 0.4 μH	Coilcraft XFL4020-102, XAL4020-401, TOKO DEF252012-R47
C1	Ceramic capacitor: 10 μF, 22 μF	(6.3-V, X5R, 0603), (6.3-V, X5R, 0805)
C2	Ceramic capacitor: 22 μF	(6.3-V, X5R, 0805)
C3, C4	Ceramic capacitor	Standard
R1, R2, R3	Resistor	Standard

8.2.2 Detailed Design Procedure

The first step in the design procedure is the selection of the output filter components. To simplify this process, 表 8-2 and 表 8-3 list possible inductor and capacitor value combinations.

表 8-2. Output Filter Selection (2.8-MHz Operation, FREQ = GND)

INDUCTOR VALUE (μH) ⁽³⁾	OUTPUT CAPACITOR VALUE (μF) ⁽²⁾				
	10	22	47	100	150
0.47	—	√ ⁽¹⁾	√	√	√
1	√	√	√	√	√
2.2	—	—	—	—	—
3.3	—	—	—	—	—

- (1) Typical application configuration. Other check marks indicate alternative filter combinations.
- (2) Capacitance tolerance and bias voltage de-rating is anticipated. The effective capacitance varies by +20% and –50%.
- (3) Inductor tolerance and current de-rating is anticipated. The effective inductance varies by +20% and –30%.

表 8-3. Output Filter Selection (1.4-MHz Operation, FREQ = V_{IN})

INDUCTOR VALUE (μH) ⁽³⁾	OUTPUT CAPACITOR VALUE (μF) ⁽²⁾				
	10	22	47	100	150
0.47	—	√	√	√	√
1	√	√ ⁽¹⁾	√	√	√
2.2	√	√	√	√	√
3.3	—	—	—	—	—

- (1) Typical application configuration. Other check marks indicate alternative filter combinations.
- (2) Capacitance tolerance and bias voltage de-rating is anticipated. The effective capacitance varies by +20% and –50%.
- (3) Inductor tolerance and current de-rating is anticipated. The effective inductance varies by +20% and –30%.

8.2.2.1 Inductor Selection

The inductor selection is affected by several parameters such as inductor-ripple current, output-voltage ripple, transition point into power save mode, and efficiency. See 表 8-4 for typical inductors.

表 8-4. Inductor Selection

INDUCTOR VALUE	COMPONENT SUPPLIER	SIZE (L × W × H mm)	Isat / DCR
0.6 μH	Coilcraft XAL4012-601	4 × 4 × 2.1	7.1 A / 9.5 m Ω
1 μH	Coilcraft XAL4020-102	4 × 4 × 2.1	5.9 A / 13.2 m Ω
1 μH	Coilcraft XFL4020-102	4 × 4 × 2.1	5.1 A / 10.8 m Ω
0.47 μH	TOKO DFE252012 R47	2.5 × 2 × 1.2	3.7 A / 39 m Ω
1 μH	TOKO DFE252012 1R0	2.5 × 2 × 1.2	3.0 A / 59 m Ω
0.68 μH	TOKO DFE322512 R68	3.2 × 2.5 × 1.2	3.5 A / 37 m Ω
1 μH	TOKO DFE322512 1R0	3.2 × 2.5 × 1.2	3.1 A / 45 m Ω

In addition, the inductor must be rated for the appropriate saturation current and DC resistance (DCR). The inductor must be rated for a saturation current as high as the typical switch current limit, of 4.6 A or according to 式 5 and 式 6. 式 5 and 式 6 calculate the maximum inductor current under static load conditions. The formula takes the converter efficiency into account. The converter efficiency is taken from the セクション 6.6 graphs or 80% can be used as a conservative approach. The calculation must be done for the maximum input voltage where the peak switch current is highest.

$$I_L = I_{OUT} + \frac{\Delta I_L}{2} \quad (5)$$

$$I_L = I_{OUT} + \frac{V_{OUT}}{\eta} \times \left(1 - \frac{V_{OUT}}{V_{IN} \times \eta}\right) \quad (6)$$

where

- f = Converter switching frequency (typical 2.8 MHz or 1.4 MHz)
- L = Selected inductor value
- η = Estimated converter efficiency (use the number from the efficiency curves or 0.80 as an conservative assumption)

Note

The calculation must be done for the maximum input voltage of the application

Calculating the maximum inductor current using the actual operating conditions gives the minimum saturation current. A margin of 20% must be added to cover for load transients during operation.

8.2.2.2 Input and Output Capacitor Selection

For best output and input voltage filtering, low-ESR (X5R or X7R) ceramic capacitors are recommended. The input capacitor minimizes input voltage ripple, suppresses input voltage spikes and provides a stable system rail for the device. A 10- μ F or larger input capacitor is recommended when FREQ = Low and a 22- μ F or larger when FREQ = High.

The output capacitor value can range from 10 μ F up to 150 μ F and beyond. Load transient testing and measuring the bode plot are good ways to verify stability with larger capacitor values. The recommended typical output capacitor value is 22 μ F (nominal) and can vary over a wide range as outline in the output filter selection table. For output voltages above 1.8 V, noise can cause duty cycle jitter. This does not degrade device performance. Using an output capacitor of 2×22 μ F (nominal) for output voltages >1.8 V avoids duty cycle jitter.

Ceramic capacitor have a DC-Bias effect, which has a strong influence on the final effective capacitance. Choose the right capacitor carefully in combination with considering its package size and voltage rating.

8.2.2.3 Setting the Output Voltage

The output voltage is set by an external resistor divider according to 式 7, 式 8, and 式 9.

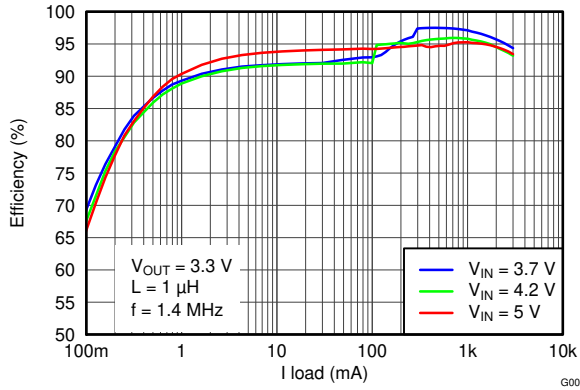
$$V_{OUT} = V_{FB} \times \left(1 + \frac{R1}{R2}\right) = 0.8 \text{ V} \times \left(1 + \frac{R1}{R2}\right) \quad (7)$$

$$R2 = \frac{V_{FB}}{I_{FB}} = \frac{0.8 \text{ V}}{5 \mu\text{A}} \approx 160 \text{ k}\Omega \quad (8)$$

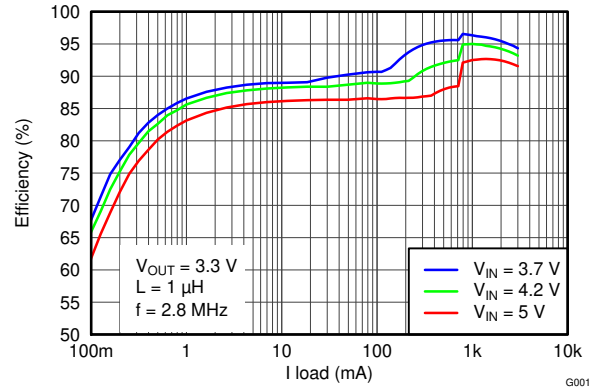
$$R1 = R2 \times \left(\frac{V_{OUT}}{V_{FB}} - 1\right) = R2 \times \left(\frac{V_{OUT}}{0.8\text{V}} - 1\right) \quad (9)$$

When sizing R2, use a minimum of 5 μ A for the feedback current (I_{FB}) to achieve low quiescent current and acceptable noise sensitivity. Larger currents through R2 improve noise sensitivity and output voltage accuracy. A feed-forward capacitor is not required for proper operation.

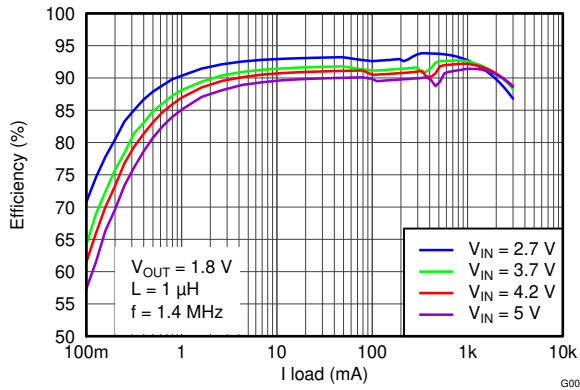
8.2.3 Application Curves



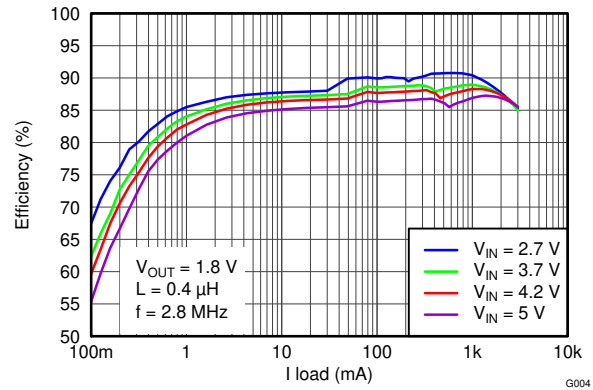
8-2. Efficiency vs Load Current



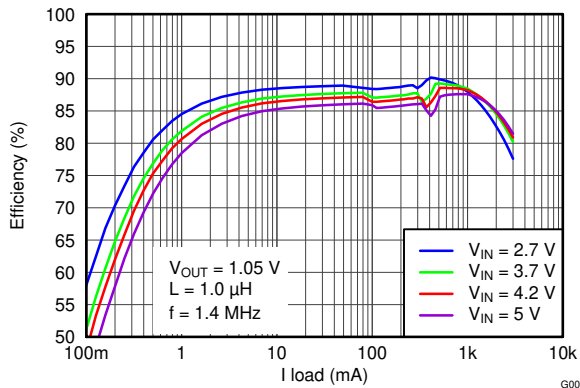
8-3. Efficiency vs Load Current



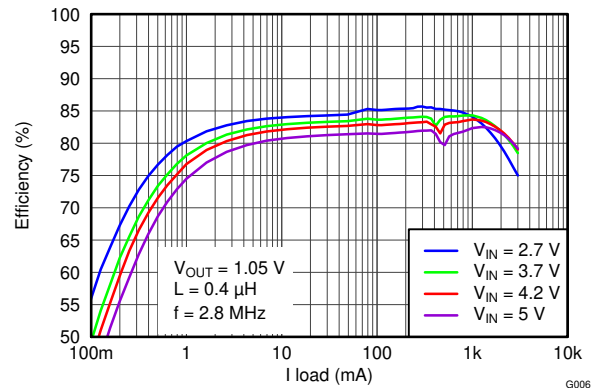
8-4. Efficiency vs Load Current



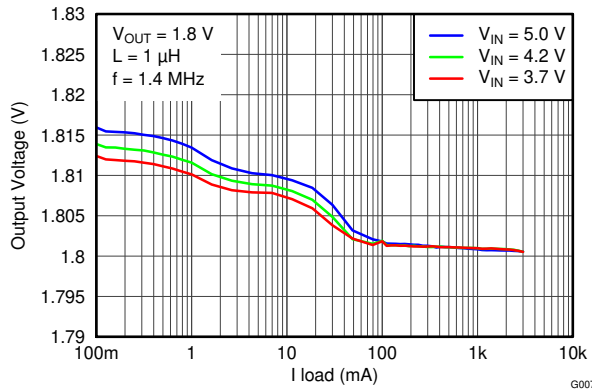
8-5. Efficiency vs Load Current



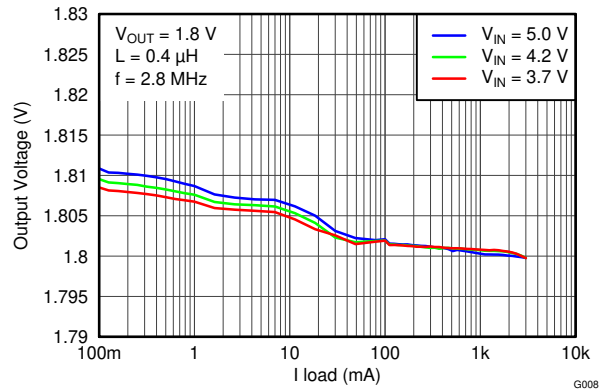
8-6. Efficiency vs Load Current



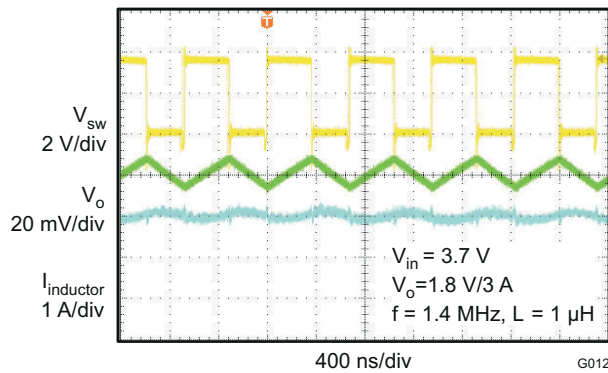
8-7. Efficiency vs Load Current



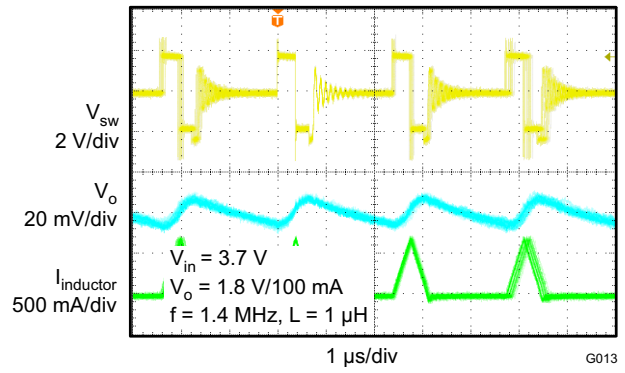
8-8. Output Voltage vs Load Current



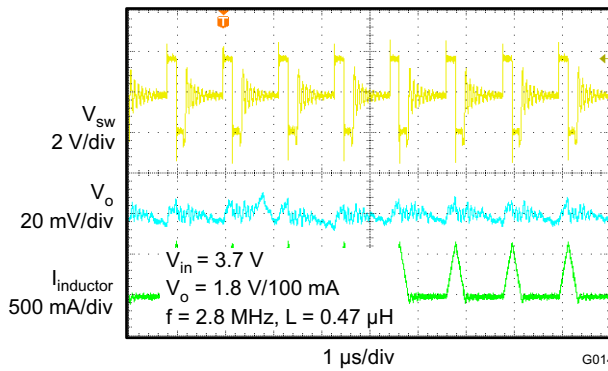
8-9. Output Voltage vs Load Current



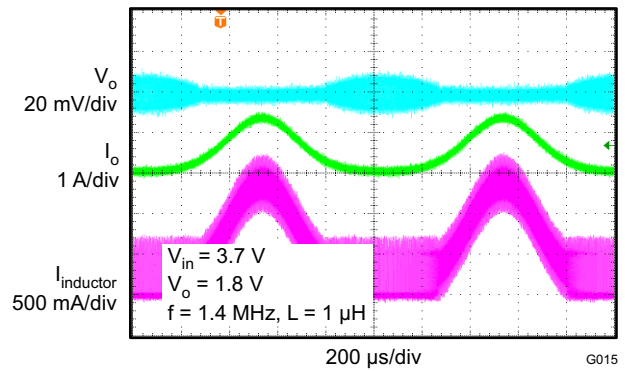
8-10. PWM Operation



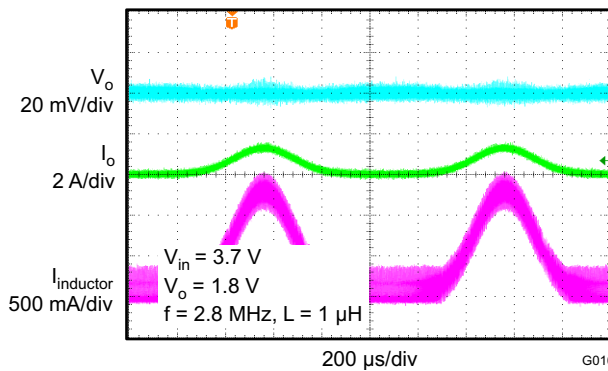
8-11. PFM Operation



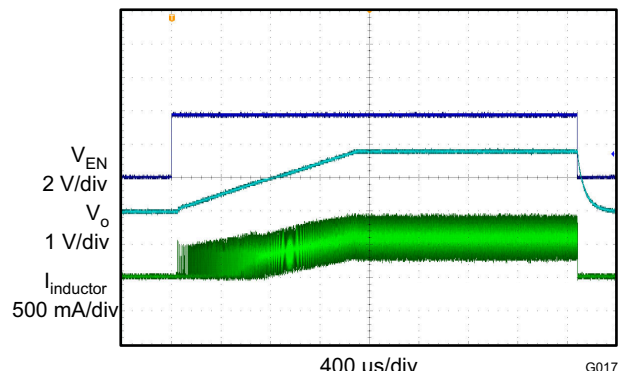
8-12. PFM Operation



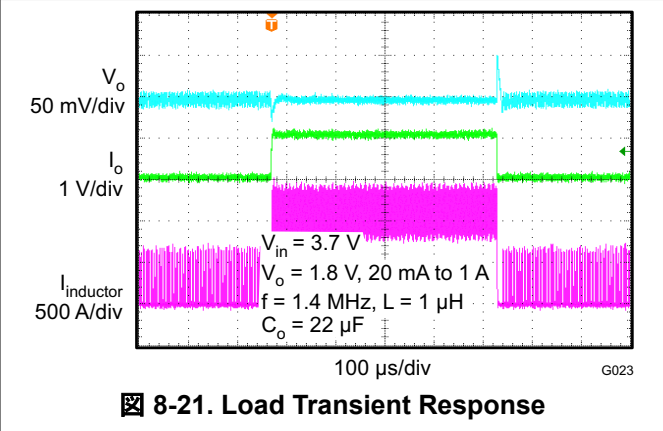
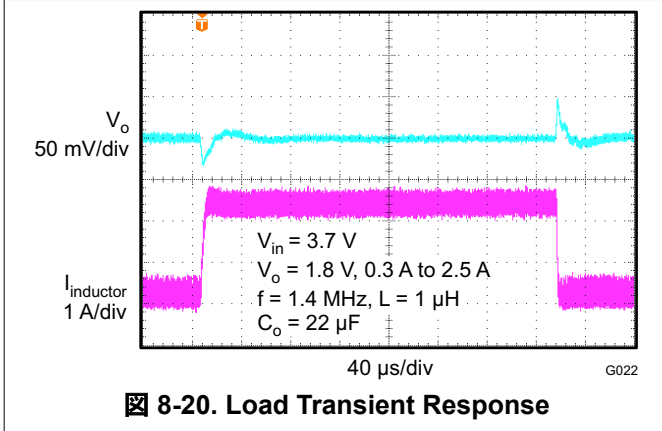
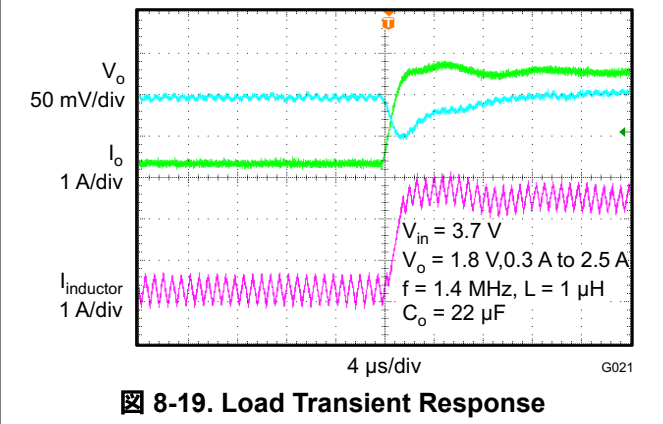
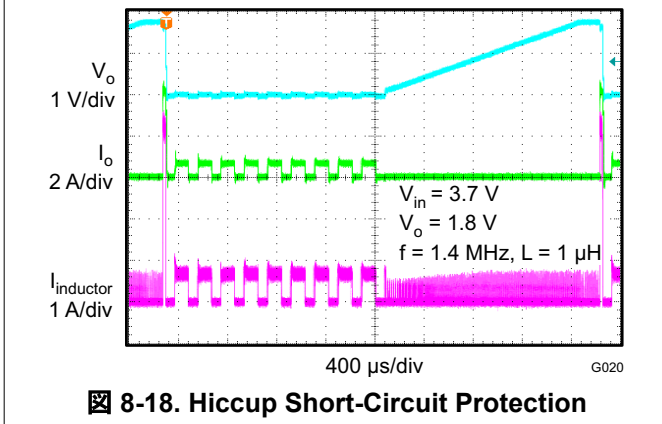
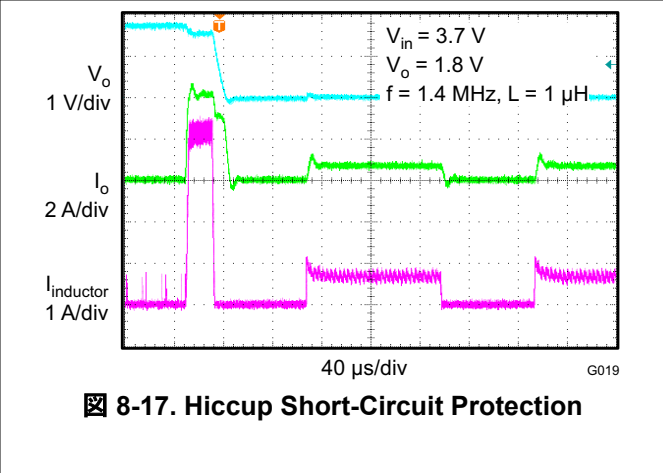
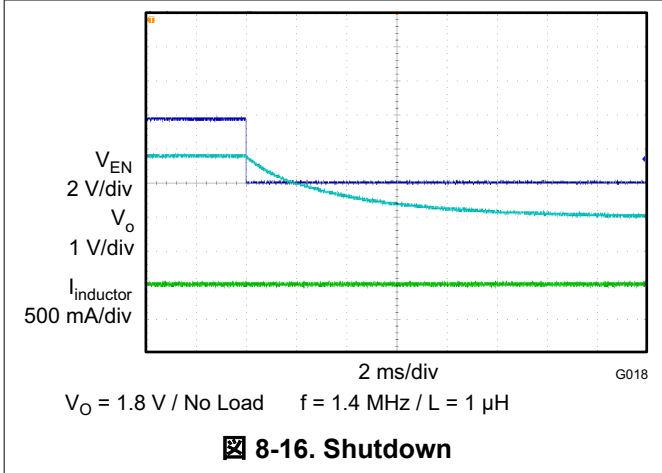
8-13. Load Sweep



8-14. Load Sweep

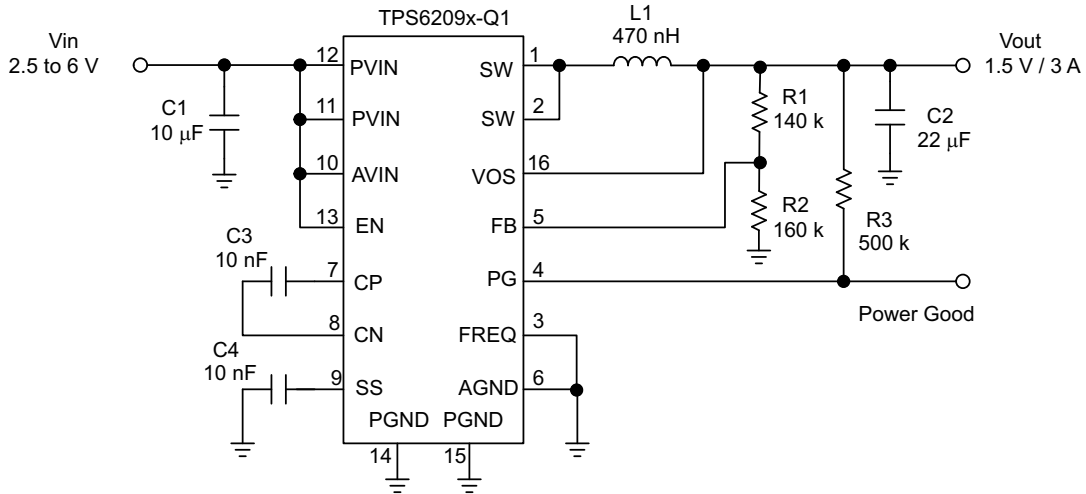


8-15. Start-Up



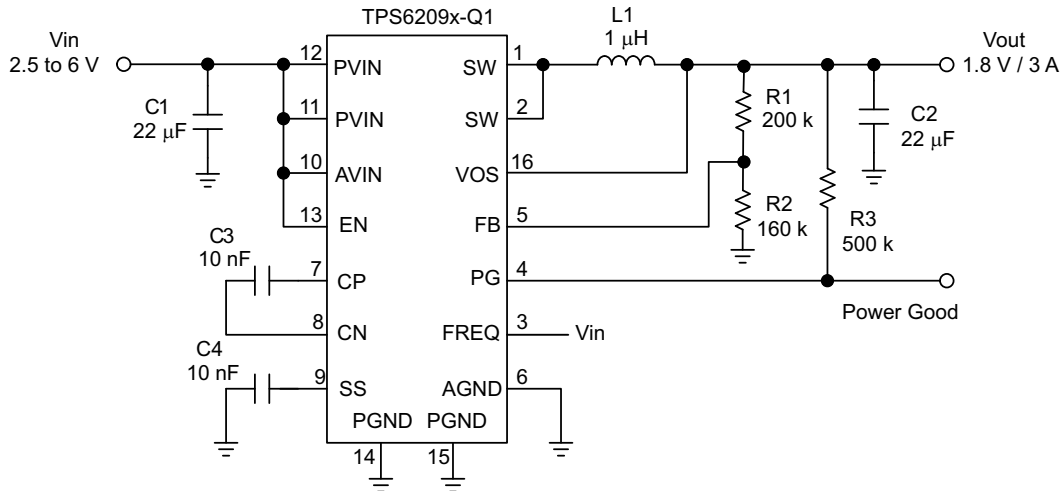
8.3 System Examples

8-22, 8-23, and 8-24 show additional circuits for varying voltage options.



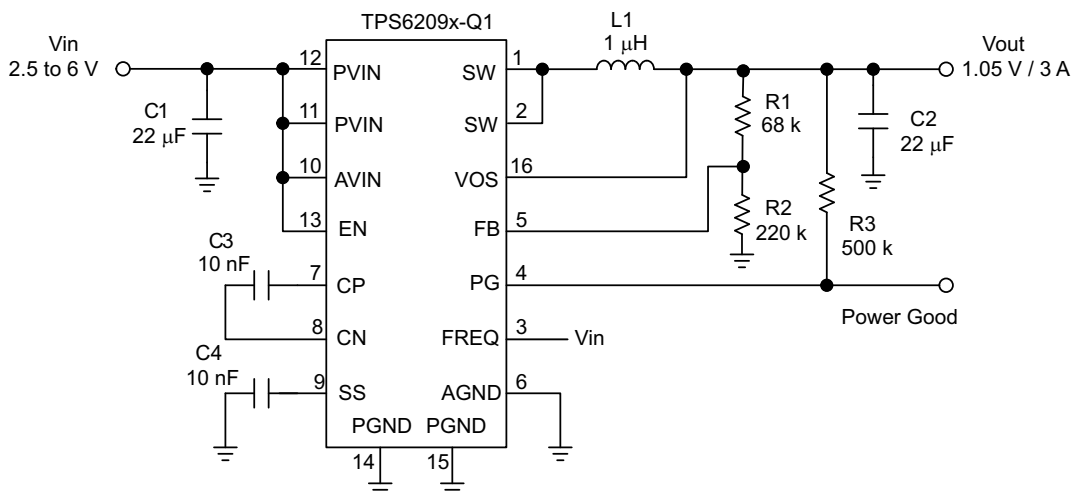
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8-22. 1.5-V Adjustable Version Operating at 2.8 MHz



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8-23. 1.8-V Adjustable Version Operating at 1.4 MHz



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8-24. 1.05-V Adjustable Version Operating at 1.4 MHz

9 Power Supply Recommendations

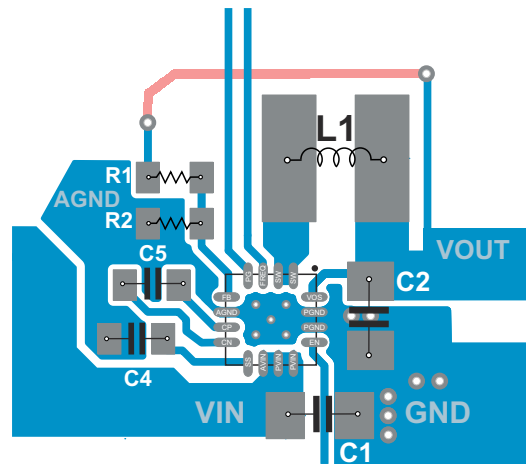
The power supply to the TPS62090-Q1 device must have a current rating according to the supply voltage, output voltage, and output current of the TPS62090-Q1 device.

10 Layout

10.1 Layout Guidelines

- TI recommends placing the input capacitor as close as possible to the IC pins PVIN and PGND.
- The VOS connection is noise sensitive and needs to be routed as short and directly to the output pin of the inductor.
- The exposed thermal pad of the package, analog ground (pin 6) and power ground (pin 14, 15) should have a single joint connection at the exposed thermal pad of the package. This minimizes switch node jitter.
- The charge pump capacitor connected to CP and CN should be placed close to the IC to minimize coupling of switching waveforms into other traces and circuits.
- Refer to the [TPS62090EVM-063 Evaluation Module](#) (SLVU670) for an example of component placement, routing, and thermal design.

10.2 Layout Example



10-1. TPS62090Q Layout

11 Device and Documentation Support

11.1 Device Support

11.1.1 Third-Party Products Disclaimer

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11.2 Documentation Support

11.2.1 Related Documentation

For related documentation see the following:

- [Basic Calculation of a Buck Converter's Power Stage](#) (SLVA477)
- [Choosing an Appropriate Pull-up/Pull-down Resistor for Open Drain Outputs](#) (SLVA485)
- [How to Measure the Control Loop of DCS-Control™ Devices](#) (SLVA465)
- [Optimizing the TPS62090 Output Filter](#) (SLVA519)
- [Performing Accurate PFM Mode Efficiency Measurements](#) (SLVA236)
- [QFN/SON PCB Attachment](#) (SLUA271)
- [TPS62090EVM-063 Evaluation Module](#) (SLVU670)
- [Understanding the Absolute Maximum Ratings of the SW Node](#) (SLVA494)

11.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](#). Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.4 サポート・リソース

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11.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.7 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS62090QRGTRQ1	ACTIVE	VQFN	RGT	16	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	SJG	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TPS62090-Q1 :

- Catalog : [TPS62090](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS62090QRGTRQ1	VQFN	RGT	16	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

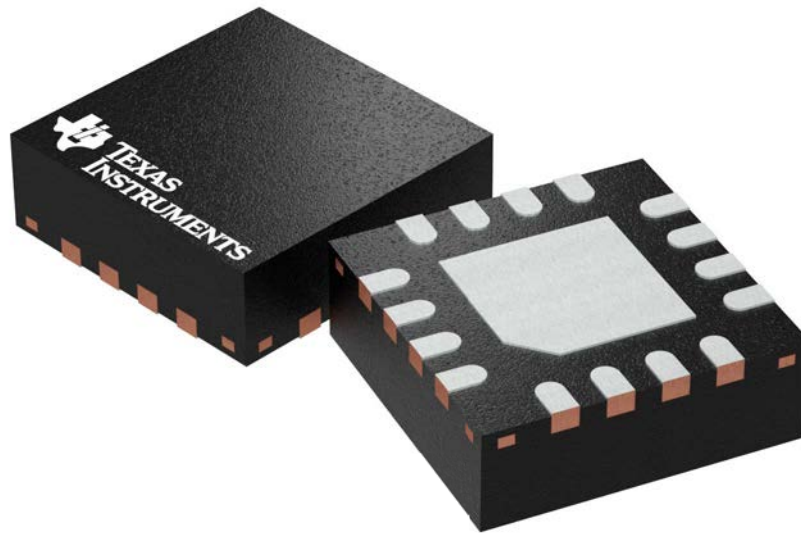
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS62090QRGTRQ1	VQFN	RGT	16	3000	346.0	346.0	33.0

RGT 16

GENERIC PACKAGE VIEW

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4203495/1



SIDE WALL METAL THICKNESS DIM A	
OPTION 1	OPTION 2
0.1	0.2



4222419/D 04/2022

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE STENCIL DESIGN

RGT0016C

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 17:
85% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:25X

4222419/D 04/2022

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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